Se	arc	ch:	N	ote	2.5



Αp	plia	catio	on/C	Con	trol	No.

10/786,684

Examiner

Dustin Nguyen

HAMURA, SHIGEKI

Applicant(s)/Patent under Reexamination

Art Unit

2154

SEARCHED					
Class	Subclass	Date	Examiner		
709	203, 206	10/25/2007	DN		
725	80, 105	10/25/2007	DN		
710	15	10/25/2007	DN		
455	423	10/25/2007	DN		
386	83	10/25/2007	DN		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
,				

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
search EAST	10/25/2007	DN	